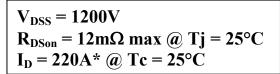
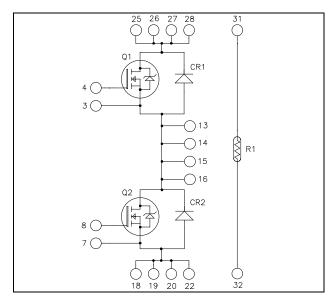


Phase leg SiC MOSFET Power Module





Application Welding converters

- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

SiC Power MOSFET

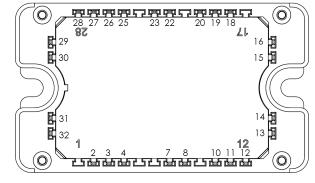
- High speed switching
- Low R_{DS(on)}
- Ultra low loss

SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance



- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS Compliant**



Pins 25 to 28 must be shorted together Pins 13 to 16 must be shorted together Pins 18/19/20/22 must be shorted together

All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1200	V
ī	Continuous Drain Current	$T_c = 25$ °C	220*	
I_D	Continuous Diain Current	$T_c = 80$ °C	165*	Α
I_{DM}	Pulsed Drain current		440	
V_{GS}	Gate - Source Voltage		-10/25V	V
R_{DSon}	Drain - Source ON Resistance		12	$m\Omega$
P_{D}	Maximum Power Dissipation	$T_c = 25^{\circ}C$	925	W

^{*} Specification of device but current must be limited due to size of pins.

Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 120$			300	μA	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		8	12	
		$I_{\rm D} = 150 A$	$T_{i} = 150^{\circ}C$		14	21	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 30$ m	2.1	2.4		V	
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.8	μA

Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$			8.4		
C_{oss}	Output Capacitance	$V_{DS} = 1000V$			0.66		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz			0.045		
Q_{g}	Total gate Charge	$V_{GS} = -5/+20V$			483		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 800V$			138		nC
Q_{gd}	Gate – Drain Charge	$I_{\rm D} = 150 A$			150		
$T_{d(on)}$	Turn-on Delay Time	$V_{} = 5/+20V$	$V_{GS} = -5/+20V$ $V_{Bus} = 800V$		35		
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 800V$			40		
$T_{d(off)}$	Turn-off Delay Time	$I_D = 150A$, $T_J = 150^\circ$			150		ns
T_{f}	Fall Time	$R_{\rm L} = 5.3\Omega \; ; \; R_{\rm Gext} = 0$	5.7Ω		70		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_{j} = 150^{\circ}C$		3.3		mJ
E_{off}	Turn off Energy	$I_{D} = 150A$ $R_{Gext} = 6.7\Omega$	$T_j = 150^{\circ}C$		1.8		1113
R_{Gint}	Internal gate resistance				2		Ω
R_{thJC}	Junction to Case Thermal Resistar	nce				0.135	°C/W

Body diode ratings and characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{SD}	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 75A$		3.3		V
		$V_{GS} = -2V, I_{SD} = 75A$		3.1		V
t_{rr}	Reverse Recovery Time			45		ns
Q _{rr}	Reverse Recovery Charge	$I_{SD} = 150A$; $V_{GS} = -5V$ $V_{R} = 800V$; $di_{F}/dt = 3000A/\mu s$		1.2		μC
I_{rr}	Reverse Recovery Current	$V_R = 800 V$, $di_F/dt = 3000 A/\mu s$		40		A



SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1200	V
T	Reverse Leakage Current	$V_{p}=1200V$	$T_j = 25^{\circ}C$		105	600	^
I_{RRM}			$T_{j} = 175^{\circ}C$		195	1200	μA
I_F	DC Forward Current		Tc = 125°C		60		A
V_{F}	Diode Forward Voltage	$I_r = 60 A$	$T_i = 25^{\circ}C$		1.5	1.8	V
V F			$T_{i} = 175^{\circ}C$		2.2		V
Q_{C}	Total Capacitive Charge	$I_F = 60A$, $V_R = 1200V$ di/dt = 1500A/ μ s			390		nC
С	Total Campaitance	$f = 1 MHz, V_R = 400 V$	400V		279		pF
	Total Capacitance	$f = 1MHz, V_R =$	800V		201		pr
R_{thJC}	Junction to Case Thermal Resistance					0.37	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \begin{array}{l} \text{T: Thermistor temperature} \\ R_T: \text{ Thermistor value at T} \end{array}$$

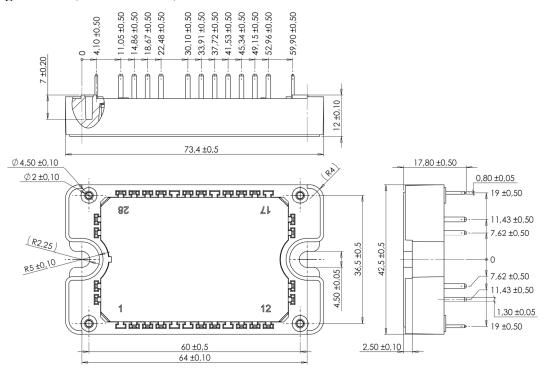
Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t	4000		V		
Т	On anoting in a tion town and two rounds		SFET	-40	150	
T_{J}	Operating junction temperature range	SiC di	ode	-40	175	
T_{JOP}	Recommended junction temperature under switching conditions				T _J max -25	°C
T_{STG}	Storage Temperature Range				125	
$T_{\rm C}$	Operating Case Temperature	-40	100			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g



Package outline (dimensions in mm)

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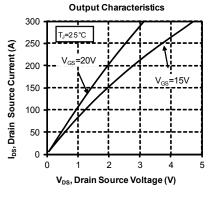


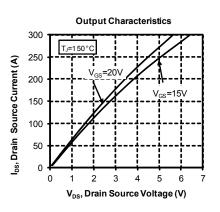
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

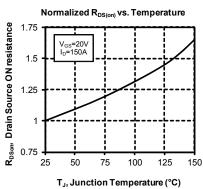
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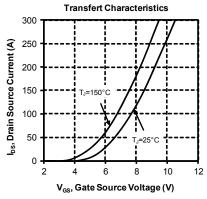


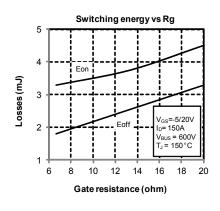
Typical SiC MOSFET Performance Curve

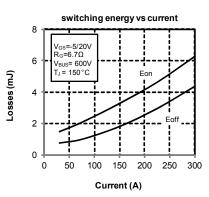


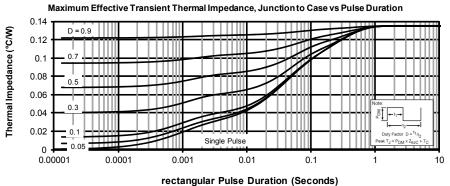




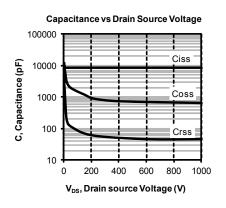


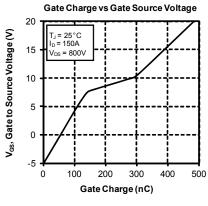


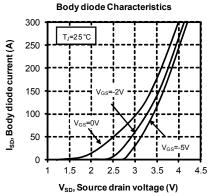


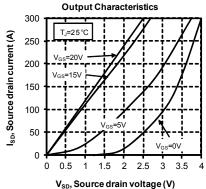


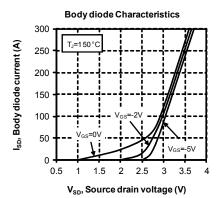


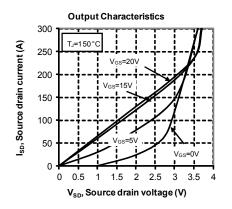


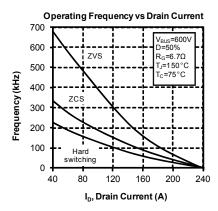








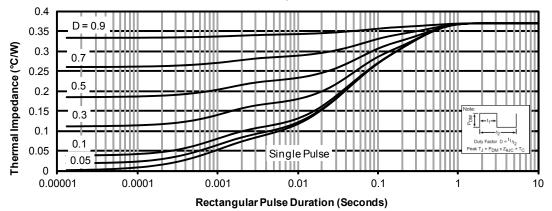


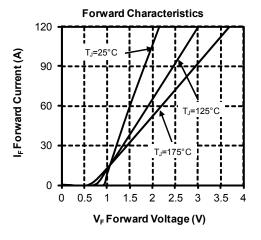


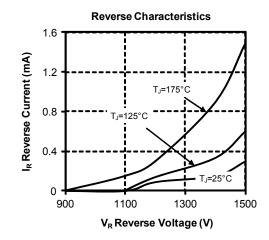


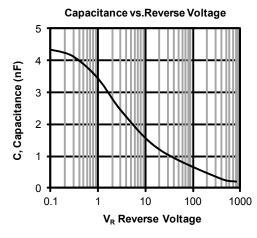
Typical SiC diode Performance Curve

Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration











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